D STATES PATENT AND TRADEMARK OFFICE

Vanhaelemeersh, et al. **Applicant** Appl. No.

09/530.069

Filed

07/03/2000

For

ANISOTROPIC ETCHING OF ORGANIC-CONTAINING

INSULATING LAYERS

Examiner Goudreau, G. Group Art Unit 1763

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: United States Patent and Trademark Office, P.O. Box 2327, Arlington, VA 22202, on

Rose M. Thiessen, Reg. No. 40,202

JUL 0 3 2002 TC: 1700

AMENDMENT

United States Patent and Trademark Office P.O. Box 2327 Arlington, VA 22202

Dear Sir:

In response to the Office Action mailed December 31, 2001 Applicants respectfully request that the Examiner enter the following amendments and consider the following remarks.

IN THE CLAIMS:

Please amend Claims 9 and 16 as follows:

9. (Twice Amended) A method for forming at least one opening in an organiccontaining insulating layer comprising the step of:

covering said organic-containing insulating layer with a bilayer, said bilayer comprising a resist hard mask layer, being formed on said organic-containing insulating layer, and a resist layer being formed on said resist hard mask layer,

patterning said bilayer, and

creating said opening by plasma etching said organic-containing insulating layer in a reaction chamber containing a gaseous mixture, said gaseous mixture comprising an oxygen-

00000026 09530069 07/01/2002 MBERHE